

Notice of References Cited	Application/Control No. 10/559,864		Applicant(s)/Patent Under Reexamination HAIK-BERAUD ET AL.	
	Examiner Ngoc-Yen M. Nguyen		Art Unit 1793	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,548,440	04-2003	Pham et al.	502/71
	B	US-			
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	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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